

Advanced Raman Microscopy used to Characterize Amorphous Carbons and Modified Graphene Layers

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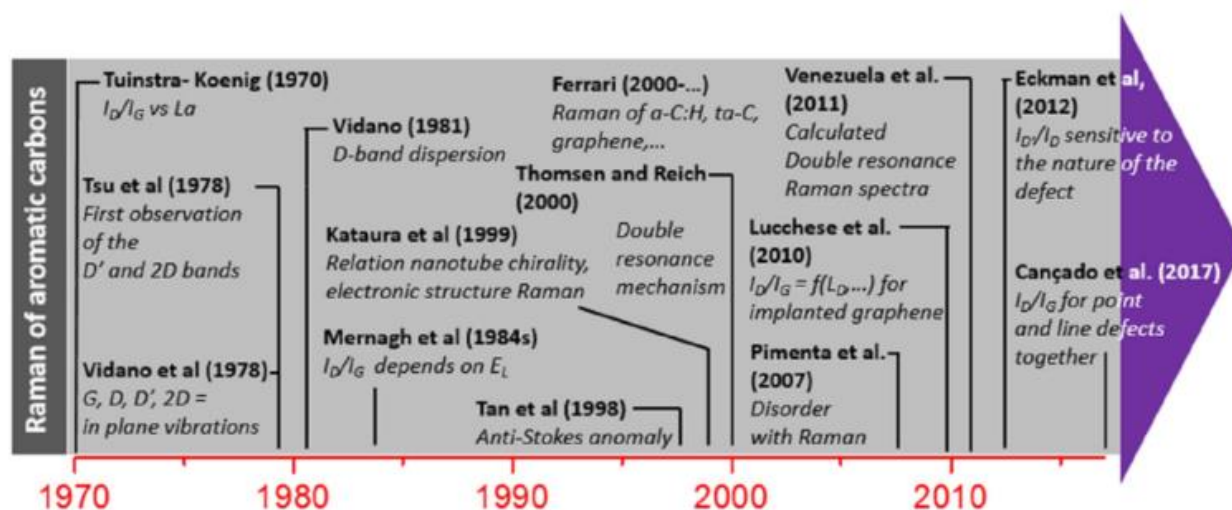
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Graphical Abstract



Raman spectroscopy applied to the study of carbons containing aromatic clusters started in the early 1970's and has been improved since then, but still some questions remain unsolved. In ¹ and ² we present its state of the art.

Abstract

Sp^2 hybridized carbons constitute a broad class of solid phases composed primarily of elemental carbon and can be either synthetic or naturally occurring. Some examples are graphite, chars, soot, graphene, carbon nanotubes, pyrolytic carbon, and diamond-like carbon. They vary from highly ordered to completely disordered solids and detailed knowledge of their internal structure and composition is of utmost importance for the scientific and engineering communities working with these materials. Multiwavelength Raman spectroscopy has proven to be a very powerful and non-destructive tool for the characterization of carbons containing both aromatic domains and defects. Depending on the material studied, some specific spectroscopic parameters (e.g., band position, full

width at half maximum, relative intensity ratio between two bands) are used to characterize defects. We review the way Raman spectroscopy is used for studying sp^2 based carbon samples containing defects, with a special focus on a-C:H layers, with post heat treatment up to 800°C. Counterintuitively, because of the electronic structure of aromatic building blocks, Raman spectra are driven by electronic properties: Phonons and electrons being coupled by the double resonance mechanism. This justifies the use of multiwavelength Raman spectroscopy to better characterize these materials. We conclude with the possible influence of both phonon confinement and curvature of aromatic planes on the shape of a-C:H and defective carbons Raman spectra. We also report on the formation of weakly interacting Multi-layer graphene by using nanomechanical folding induced by an AFM tip on CVD-transferred graphene. More precisely, vertical forces in the μN range were applied on 4 μm square zones that induced a cut and push process leading to the formation of these weakly interacting Multi-layer graphene. We highlight what kind of information can be obtained by advanced Raman microscopy.

Keywords: Raman microscopy; amorphous carbon; defective graphite; modified graphene.

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Biography of Presenting Author



Cedric Pardanaud has obtained his PhD in experimental molecular physics, working on nuclear spin conversion of water molecules embedded in cryogenic matrix, measured by infrared spectroscopy and with astrophysical interest. In 2007 he started working in the group of Pascale Roubin, developing the use of Raman microscopy applied to materials science. More precisely he was involved in plasma/wall interaction occurring in tokamaks. He started investigating, among others, amorphous carbons and defective graphite, employing a methodology based on the comparison of samples collected in tokamaks and synthesized in labs. More recently he started to study a cut and fold method to obtain graphene

multilayer from single layer graphene.

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